







Sophisticated instrument workshop ICP-MS. GC-MS and IC

EVENT INFO

Inland Empire Utilities Agency 6075 Kimball Ave Chino, CA 91708

DATE
THURSDAY, July 24, 2025
TIME
8:00 A.M. – 4:00 P.M.

CONTACT FOR MORE INFO **Sushmitha Reddy** (909)-993-1813

CWEA MEMBERS PRICE \$75.00 Non-CWEA MEMBERS PRICE \$100.00

Who Should Attend?

Lab staff preparing for Grade 2, 3, or 4 CWEA laboratory exams, particularly those new to ICP-MS, GC-MS, and IC or without access to these instruments.

REGISTER YOUR TEAM EARLY REGISTER ON CWEA'S WEBSITE **events.cwea.org**

Credit cards only, CWEA does not charge a fee. Payment method is by credit card only. No refunds, attendee substitutions allowed. The SARBS Lab Committee partnered with Thermo Fisher Scientific and Perkin Elmer to provide a comprehensive workshop on GC-MS, ICP-MS, and IC instruments. **Earn 6.9 CWEA Contact Hours** and join us to learn about operational principles and essential quality control practices.

Speakers & Sessions

- Ion Chromatography (IC): Paul Colvin, Thermo Scientific
- Inductively Coupled Plasma Mass Spectrometry (ICP-MS): Marshall Allin, Thermo Scientific and Cole Taylor, Perkin Elmer
- Gas Chromatography-Mass Spectrometry (GC-MS): Terry Jeffers, Thermo Scientific

What you'll learn

- **Basics**: Instrument overview, including components and sample flow paths.
- **Instrument Operation:** Tuning, conditioning, operational parameters, and calibration for optimal performance.
- **Demonstration**: Step-by-step walkthrough of running a sample on each of the instrument
- **Quality Control:** Calibration techniques, method validation, and troubleshooting
- **Maintenance:** Routine procedures for smooth operation and consumable inventory

Agenda

7:30 - 8:00 am

• Registration, Continental Breakfast (Sponsored by Perkin Elmer)

 $8:00-12:00 \ pm$

- Welcome
- Exam Preparation Tips: CWEA's Norah Duffy and Lydia Guerra
- Interactive Lecture on Analytical Techniques

12:00 – 1:00 pm Lunch (Sponsored by Thermo)

 $1:00-4:00 \ pm$

- Hands-On Live Interactive Instrument Use
- Panel discussion O&A Session